

# GSM5606

## 60V N & P Pair Enhancement Mode MOSFET

### Product Description

GSM5606, N & P Pair enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, and low in-line power loss are needed in commercial industrial surface mount applications.

### Features

#### N-Channel

- 60V/15A,  $R_{DS(ON)}=42m\Omega @ V_{GS}=10V$
- 60V/12A,  $R_{DS(ON)}=50m\Omega @ V_{GS}=4.5V$

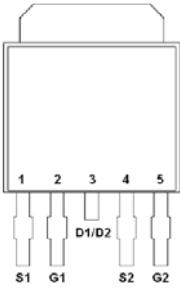
#### P-Channel

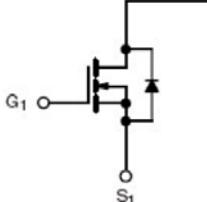
- -60V/-15A,  $R_{DS(ON)}=100m\Omega @ V_{GS}=-10V$
- -60V/-12A,  $R_{DS(ON)}=120m\Omega @ V_{GS}=-4.5V$

### Applications

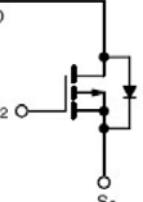
- DC/DC Conversion
- Load Switch
- DC FAN

### Packages & Pin Assignments

GSM5606DF(TO-252-4L)				
				
Pin	Description	Pin	Description	
1	Source1	4	Source2	
2	Gate1	5	Gate2	
3	Drain 1/2			

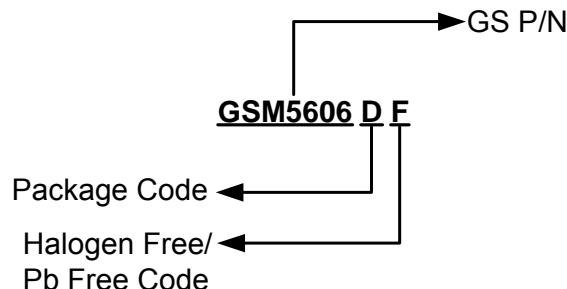


N-Channel MOSFET



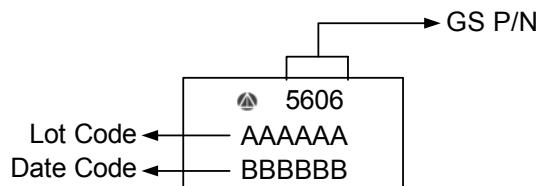
P-Channel MOSFET

## Ordering Information



Part Number	Package	Quantity Reel
GSM5606DF	TO-252-4L	2500 PCS

## Marking Information



## Absolute Maximum Ratings (N-Channel)

(T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Typical	Unit
V <sub>DSS</sub>	Drain-Source Voltage	60	V
V <sub>GSS</sub>	Gate -Source Voltage	±20	V
I <sub>D</sub>	Continuous Drain Current(T <sub>J</sub> =150°C)	7.0	A
	T <sub>A</sub> =25°C	7.0	
	T <sub>A</sub> =70°C	6.0	
I <sub>DM</sub>	Pulsed Drain Current	20	A
I <sub>S</sub>	Continuous Source Current(Diode Conduction)	1.5	A
P <sub>D</sub>	Power Dissipation	2.8	W
	T <sub>A</sub> =25°C	2.8	
	T <sub>A</sub> =70°C	1.8	
T <sub>J</sub>	Operating Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	-55/150	°C
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	62.5	°C/ W

## Electrical Characteristics (N-Channel)

( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	60			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0		2.5	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$			1	
		$V_{DS}=60\text{V}, V_{GS}=0\text{V}, T_J=85^\circ\text{C}$			5	uA
$I_{D(\text{on})}$	On-State Drain Current	$V_{DS}\geq 5\text{V}, V_{GS}=4.5\text{V}$	30			A
$R_{DS(\text{on})}$	Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=15\text{A}$		38	42	
		$V_{GS}=4.5\text{V}, I_D=12\text{A}$		42	50	mΩ
$g_{FS}$	Forward Transconductance	$V_{DS}=15\text{V}, I_D=5.3\text{A}$		24		S
$V_{SD}$	Diode Forward Voltage	$I_S=2.0\text{A}, V_{GS}=0\text{V}$	0.8	1.2		V
<b>Dynamic</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=30\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		890		
$C_{oss}$	Output Capacitance			85		pF
$C_{rss}$	Reverse Transfer Capacitance			48		
$Q_g$	Total Gate Charge	$V_{DS}=30\text{V}, V_{GS}=5\text{V}, I_D=5.6\text{A}$		10	15	
$Q_{qs}$	Gate-Source Charge			3.5		nC
$Q_{qd}$	Gate-Drain Charge			3.6		
$t_{d(on)}$	Turn-On Time	$V_{DD}=30\text{V}, R_L=6.8\Omega, I_D=5.0\text{A}, V_{GEN}=4.5\text{V}, R_G=6\Omega$		10	15	
$T_r$				12	20	
$t_{d(off)}$	Turn-Off Time			25	35	
$T_f$				10	15	ns

## Absolute Maximum Ratings (P-Channel)

( $T_A=25^\circ\text{C}$  unless otherwise noted)

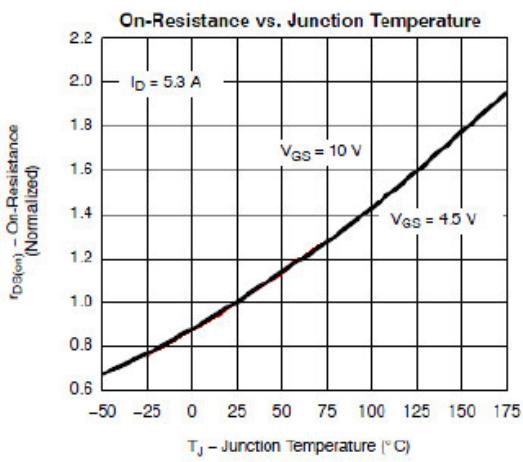
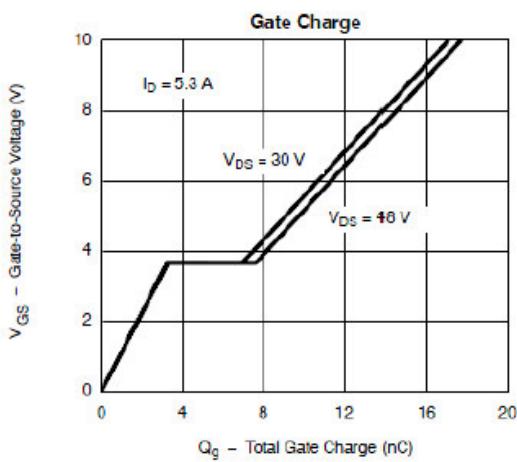
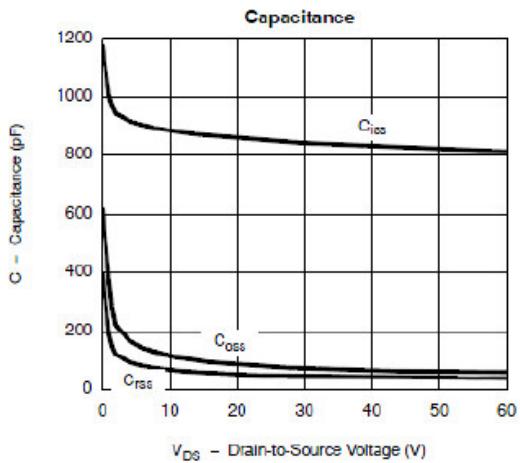
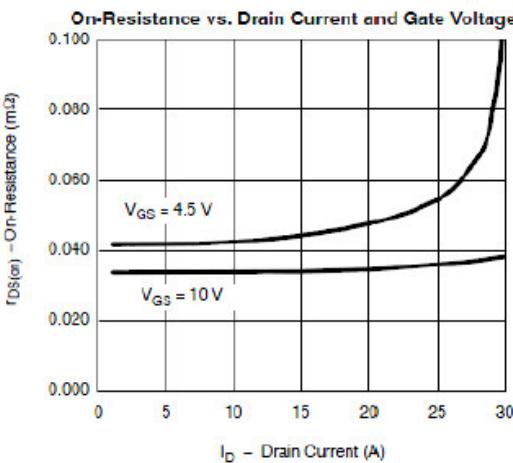
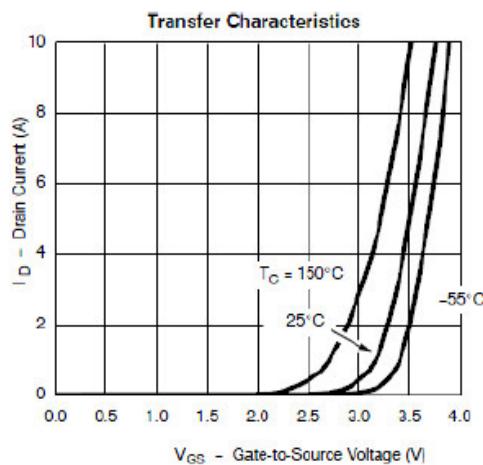
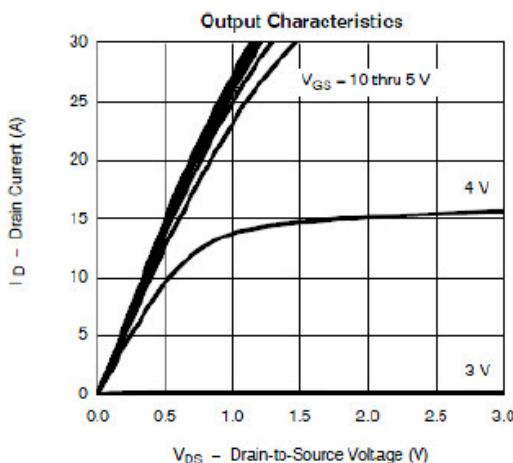
Symbol	Parameter	Typical	Unit
$V_{DSS}$	Drain-Source Voltage	-60	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current( $T_J=150^\circ\text{C}$ )	$T_A=25^\circ\text{C}$	-5.0
		$T_A=70^\circ\text{C}$	-4.0
$I_{DM}$	Pulsed Drain Current	-30	A
$I_S$	Continuous Source Current(Diode Conduction)	-1.7	A
$P_D$	Power Dissipation	$T_A=25^\circ\text{C}$	2.8
		$T_A=70^\circ\text{C}$	1.8
$T_J$	Operating Junction Temperature	150	°C
$T_{STG}$	Storage Temperature Range	-55/150	°C
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5	°C/W

## Electrical Characteristics (P-Channel)

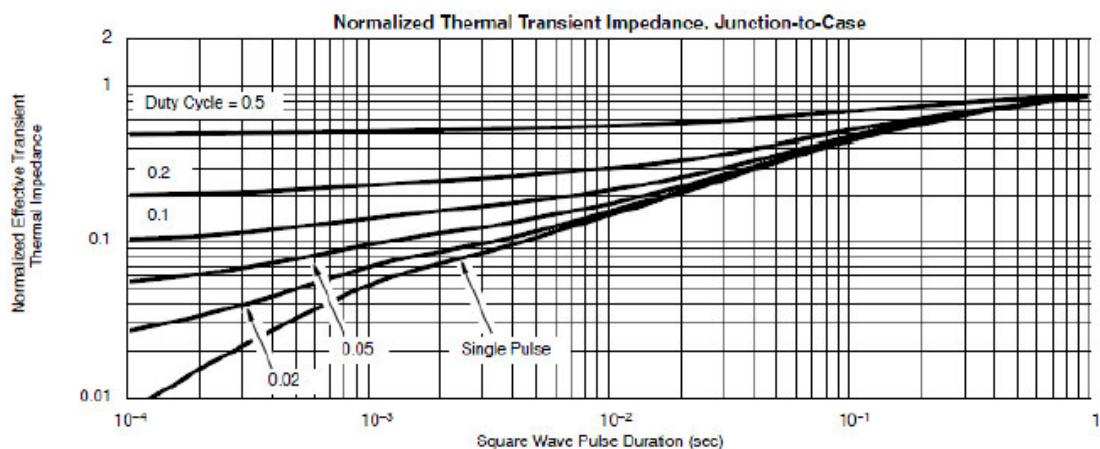
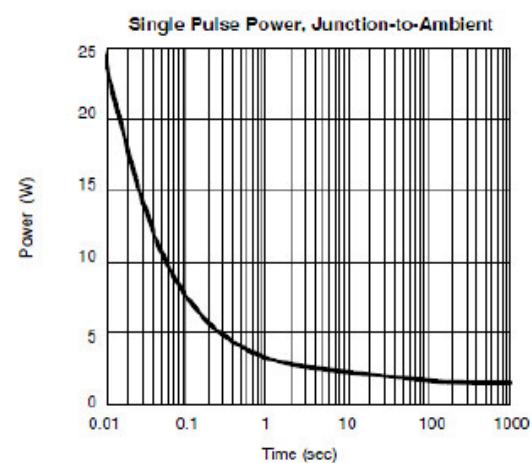
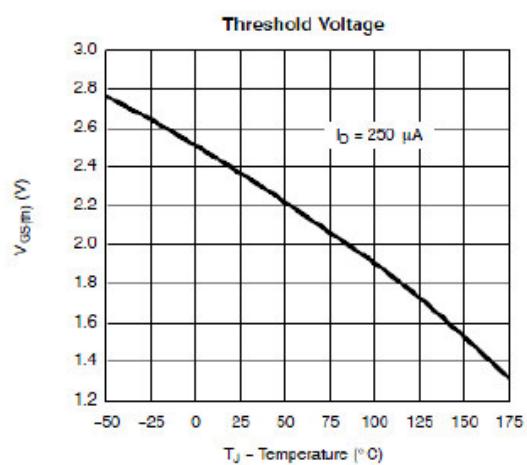
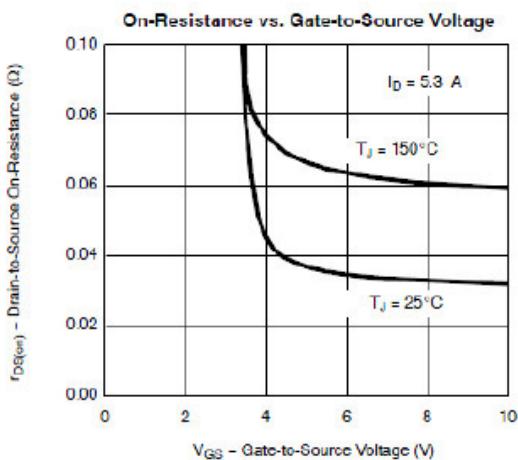
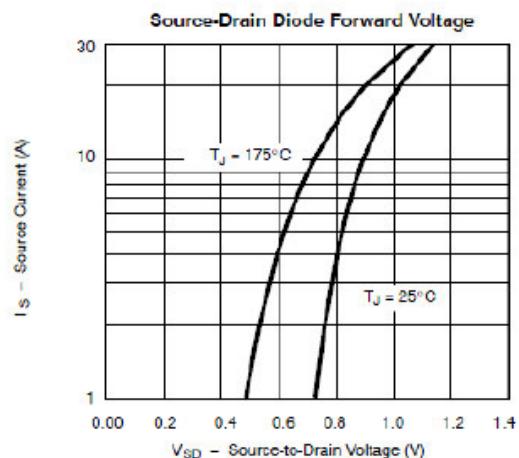
( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-60			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-0.8		-2.5	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$		$\pm 100$		nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-48\text{V}, V_{GS}=0\text{V}$		-1		uA
		$V_{DS}=-48\text{V}, V_{GS}=0\text{V}, T_J=85^\circ\text{C}$		-20		
$I_{D(\text{on})}$	On-State Drain Current	$V_{DS}\leq -5\text{V}, V_{GS}=-10\text{V}$	-20			A
$R_{DS(\text{on})}$	Drain-Source On-Resistance	$V_{GS}=-10\text{V}, I_D=-15\text{A}$	88	100		mΩ
		$V_{GS}=-4.5\text{V}, I_D=-12\text{A}$	98	120		
$g_{FS}$	Forward Transconductance	$V_{DS}=-15\text{V}, I_D=-3.2\text{A}$	12			S
$V_{SD}$	Diode Forward Voltage	$I_S=-2\text{A}, V_{GS}=0\text{V}$	-0.8	-1.2		V
<b>Dynamic</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-30\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		900		pF
$C_{oss}$	Output Capacitance			90		
$C_{rss}$	Reverse Transfer Capacitance			40		
$Q_g$	Total Gate Charge	$V_{DS}=-30\text{V}, V_{GS}=-10\text{V}, I_D=-4.0\text{A}$		12	20	nC
$Q_{gs}$	Gate-Source Charge			2.5		
$Q_{gd}$	Gate-Drain Charge			3.5		
$t_{d(\text{on})}$	Turn-On Time	$V_{DD}=-30\text{V}, R_L=7.5\Omega, I_D=-3.0\text{A}, V_{GEN}=-10\text{V}, R_G=3\Omega$		10	20	ns
$T_r$				6	10	
$t_{d(\text{off})}$	Turn-Off Time			30	45	
$T_f$				12	25	

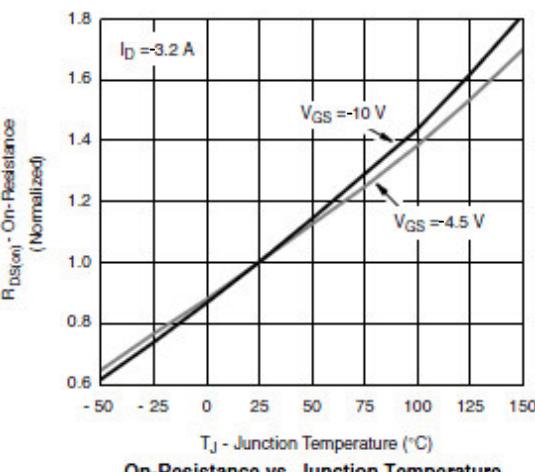
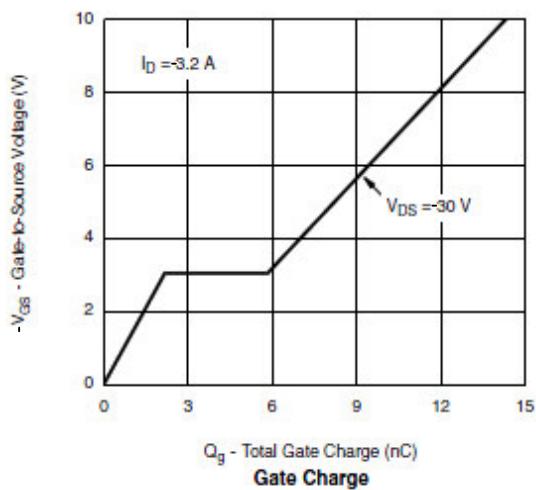
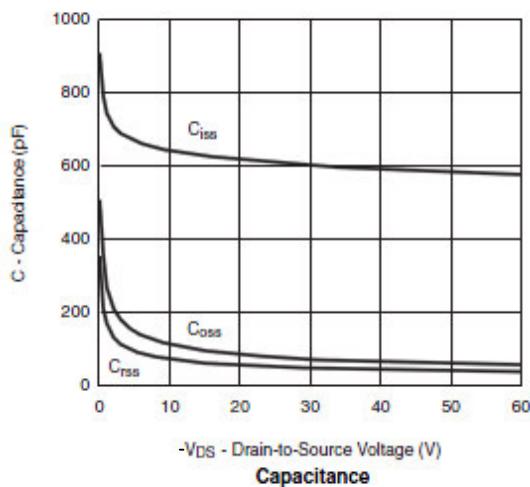
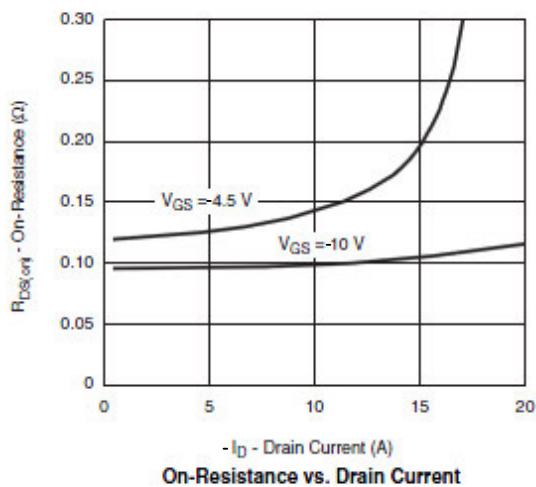
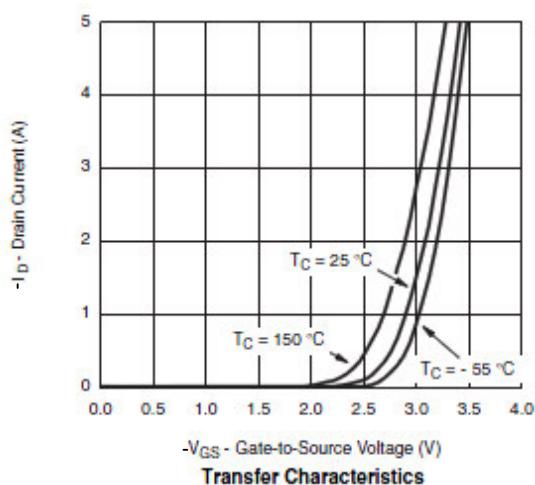
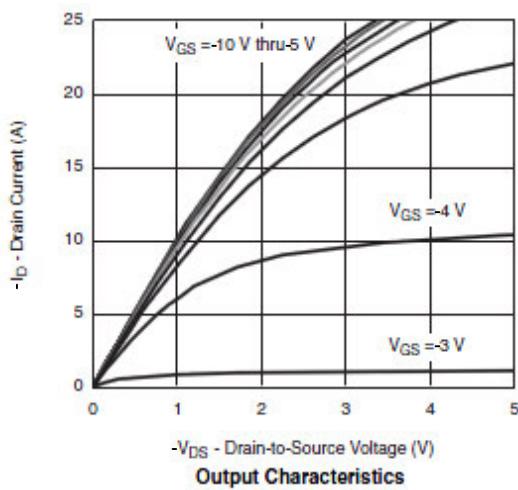
## Typical Performance Characteristics (N-Channel)



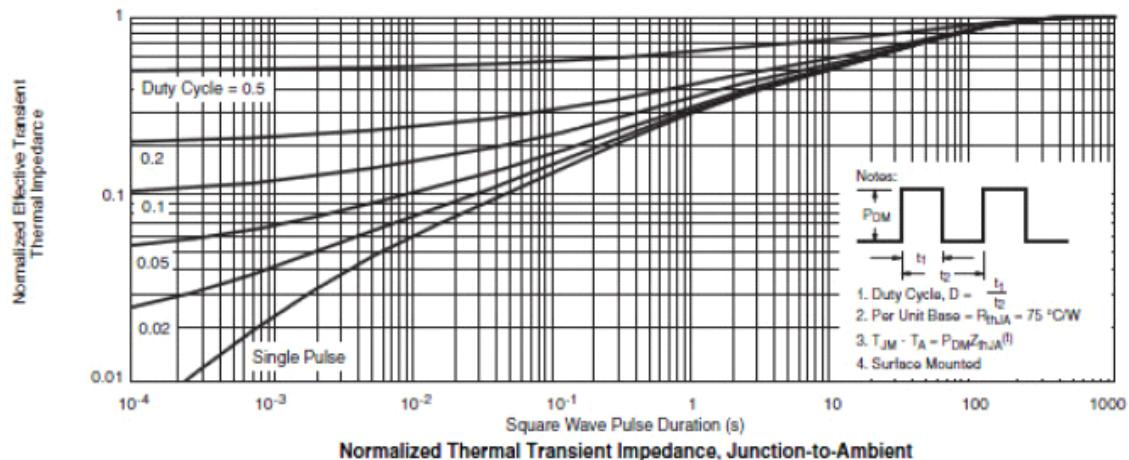
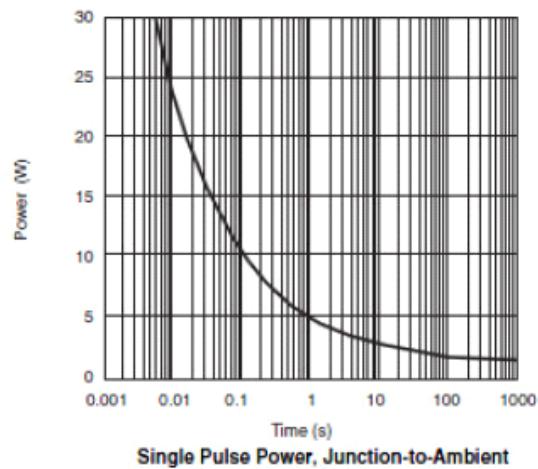
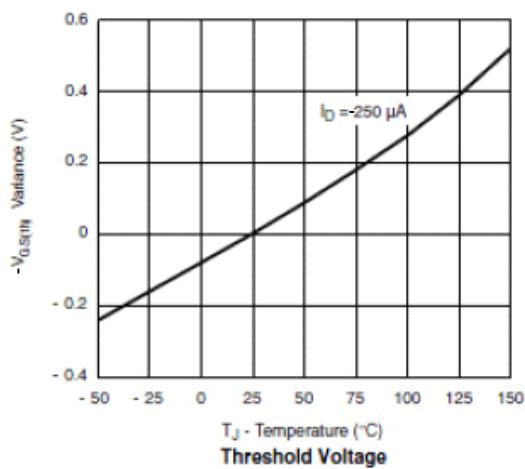
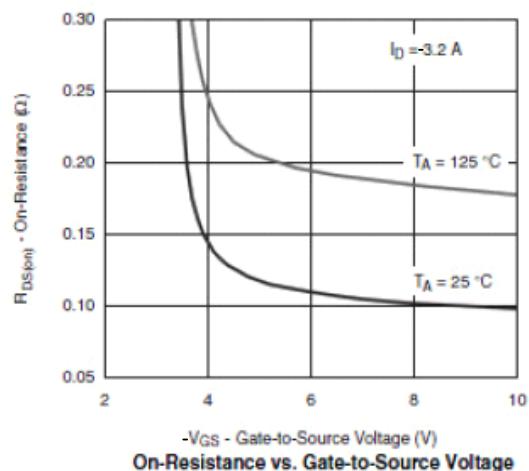
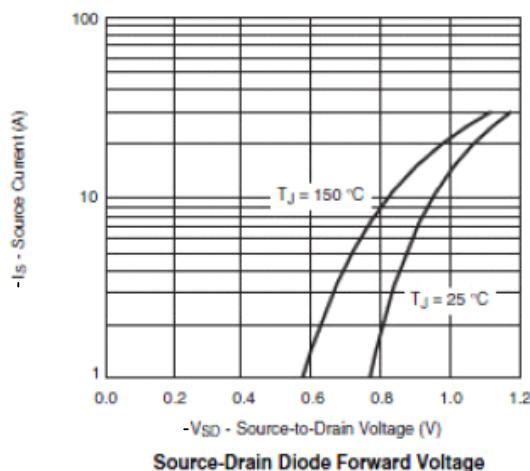
## Typical Performance Characteristics (N-Channel)



## Typical Performance Characteristics (P-Channel)

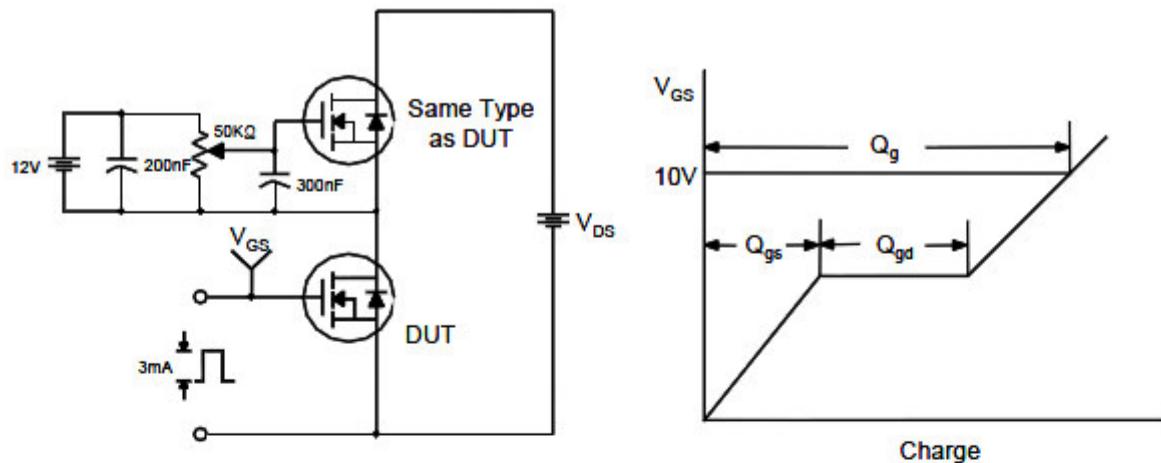


## Typical Performance Characteristics (P-Channel)

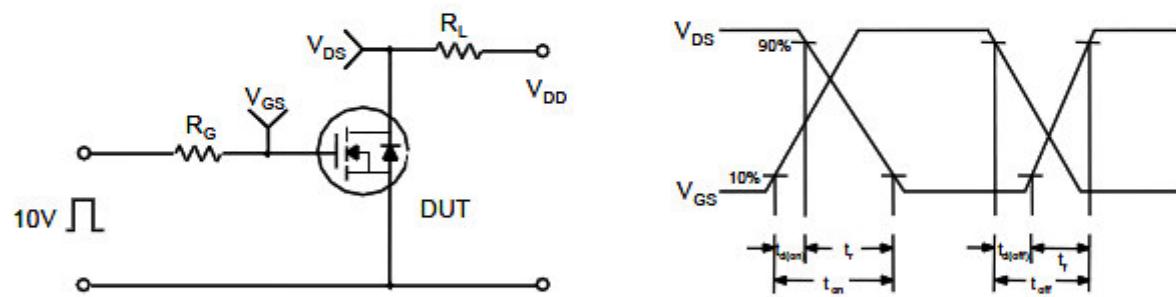


## Typical Performance Characteristics

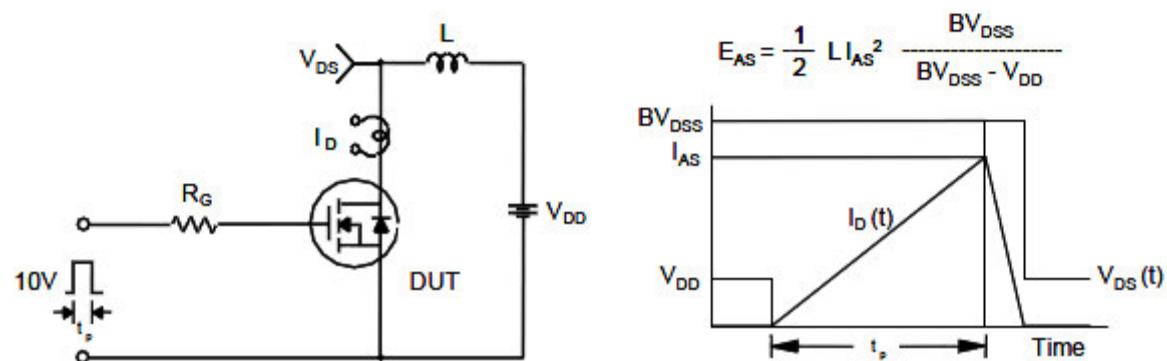
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

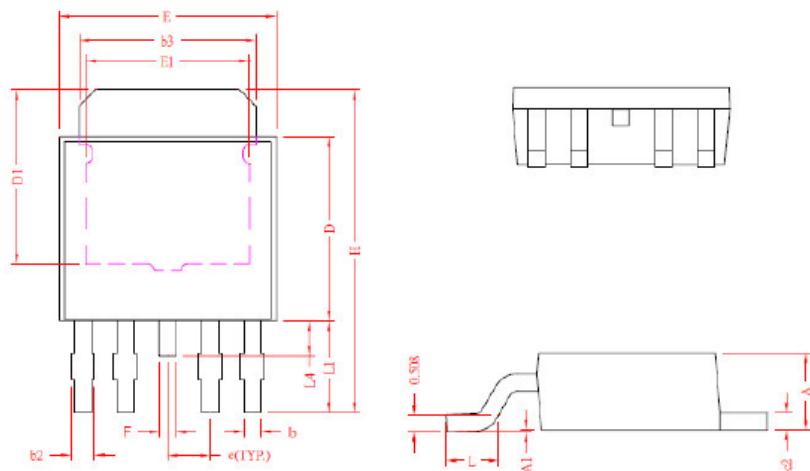


Unclamped Inductive Switching Test Circuit & Waveforms



## Package Dimension

### TO-252-4L PLASTIC PACKAGE



#### Dimensions

SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	2.20	2.40	0.086	0.094
A1	0	0.15	0	0.005
b	0.40	0.60	0.015	0.023
b2	0.50	0.80	0.019	0.031
b3	5.20	5.50	0.204	0.216
c2	0.45	0.55	0.017	0.021
D	5.40	5.80	0.212	0.228
D1	4.57	-	0.179	-
E	6.40	6.80	0.251	0.267
E1	3.81	-	0.150	-
e	1.27 (REF)		0.05 (REF)	
F	0.40	0.60	0.015	0.023
H	9.40	10.20	0.370	0.401
L	1.40	1.77	0.055	0.069
L1	2.40	3.00	0.094	0.118
L4	0.80	1.20	0.031	0.047

GSM5606

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